

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Group Art Unit: 2895

Examiner: Swapneel CHHAYA

In Re PATENT APPLICATION of:

Takamitsu YAMANAKA Applicant(s): U.S. Serial No.: 10/577,457 U.S. Filing Date: April 27, 2006 International Serial No.: PCT/JP2005/014208 SUPPLEMENTAL International Filing Date: August 3, 2005 <u>AMENDMENT</u> Priority Date Claimed: August 17, 2004 SEMICONDUCTOR DEVICE For: AND ITS MANUFACTURING **METHOD AI 409NP** Attorney Reference: May 17, 2010

Mail Stop AF

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In response to the Examiner's Action mailed on January 26, 2010, please amend the above-identified application as follows: